

Reliability & Failure Analysis Group

1F Xinyicheng C Building, No.1618 Yishan Rd., Shanghai City, China.

Tel: 86-21-61910691, Fax: 86-21-64069790

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Report No.: SH1908190145HE-CN

Version: A

# **ESD (HUMAN BODY MODE) TEST REPORT**

Company : 成都启英泰伦科技有限公司

Address : <u>成都市高新区孵化园 6 号楼 1 楼 106 室</u>

Model Name : CI1102

Date Received : September 7, 2019

Date Tested : September 7, 2019

# **TESTING LABORATORY IS APPROVEDED BY:**

IECQ Certificate of Approval No.: IECQ-L DEKRA 17.0004-01 For Independent Test Laboratory According to ISO/IEC 17025

ISO 9001 certificate is approved by TUV CERT certification body of TUV NORD Cert GmbH

#### WE HEREBY CERTIFY THAT:

The test(s) shown in the attachment were conducted according to the indicating procedures. We assume full responsibility for the accuracy and completeness of these tests and vouch for the qualifications of all personnel performing them.

	Name	Signature	Date
Testing Engineer	Peng Zhao	Peng_zhao	2019/9/7
Approving Manager	Kimi Lai	Kimi_Lai	2019/9/7

### Note:

- 1. This report will be invalid if reproduced in whole or in part.
- This report refers only to the specimen(s) submitted to test, and is invalid if used separately.
- This report is ONLY valid with the examination seal and signature of this institute.
- The tested specimen(s) will only be preserved for thirty days from the date issued, if not collected by the applicant.
- 5. The failure criteria of all ESD tests should be based on the result of parametric and functional testing conducted by the customer, which follows the statement of international standards. Thus, the judgment of the curve traces provided in this report is for reference ONLY.



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## 1. GENERAL INFORMATION

# 1.1 DESCRIPTION OF UNIT

MANUFACTURER : 成都启英泰伦科技有限公司

DEVICE NAME : CI1102 PACKAGED / PIN COUNT : QFN56

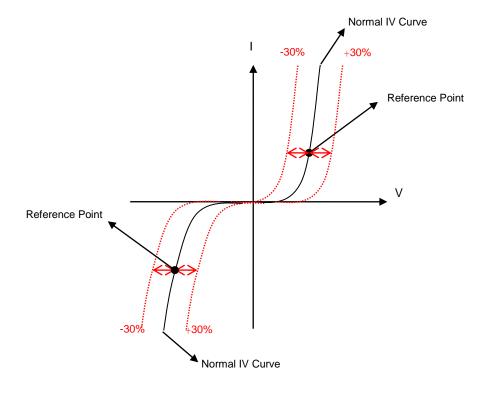
REFERENCE DOCUMENT : ANSI/ESDA/JEDEC JS-001-2017 Zap 1 pulse(s), Interval: 0.3 Sec.

TEST VOLTAGE : 2000V~8000V, step:1000V(±)

SAMPLE QUANTITY : 3 pcs

FAILURE CRITERIA : ±30% voltage shift at reference point before/after zapping

※Failure Judgment: Voltage shift over ±30% at reference point.





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# 2. ESD (HUMAN BODY MODE) TEST

#### 2.1 TEST EQUIPMENT

Test Equipment	Equipment S/N	Calibration Date:	Recommended Due Date:
KEYTEK ZAPMASTER 7/4	9503392	July 4, 2019	July 3, 2020

#### 2.2 LABORATORY AMBIENCE CONDITION

Temperature: 25±5°C

Relative humidity: 55%±10% (RH)

#### 2.3 REFERENCE DOCUMENT

The test is based on ANSI/ESDA/JEDEC JS-001-2017

#### 2.4 TEST CONDITION

ALL OTHER TO VSS (+/-)
ALL OTHER TO VSS\_PLL (+/-)
ALL OTHER TO VSS\_CODEC (+/-)
ALL OTHER TO VCC (+/-)
ALL OTHER TO AVDD\_PLL (+/-)
ALL OTHER TO VDD\_CODEC.A (+/-)
ALL OTHER TO VDD\_CODEC.B (+/-)
ALL OTHER TO VDD12 (+/-)
IO TO IO (+/-)
2000V~8000V,step:1000V



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# 2.5 SUMMARY OF TEST

Test Model : HBM	ESD Sensitivity Passed: +/-4000V		ANSI/ESDA/JEDEC JS-001-2017 Class: <u>3A</u>
Test condition	Sample Quantity	Passed Volts	Class 0Z : < 50V Class 0A : ≥ 50V , <125V
ALL OTHER TO VSS (+/-) ALL OTHER TO VSS_PLL (+/-) ALL OTHER TO VSS_CODEC (+/-) ALL OTHER TO VCC (+/-) ALL OTHER TO AVDD_PLL (+/-) ALL OTHER TO VDD_CODEC.A (+/-) ALL OTHER TO VDD_CODEC.B (+/-) ALL OTHER TO VDD12 (+/-) IO TO IO (+/-) 2000V~8000V.step:1000V	3	+/-4000V	Class 0B : $\ge$ 125V , <250V Class 1A : $\ge$ 250V , <500V Class 1B : $\ge$ 500V , <1000V Class 1C : $\ge$ 1000V , <2000V Class 2 : $\ge$ 2000V , <4000V Class 3A : $\ge$ 4000V , <8000V Class 3B : $\ge$ 8000V

**Group Pins** AVDD\_PLL 1

IO 3-6,9-20,22-35,38-43,45,47,49,51,53-56

VCC 8,21,37,52 VDD12 7,36 VDD\_CODEC.A 44 VDD\_CODEC.B 48 VSS 57 VSS\_CODEC 46,50 VSS\_PLL 2

# INTEGRATED SERVICE TECHNOLOGY

#### Integrated Service Technology Inc.

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# 2.6 CONTENTS OF TEST

No

ALL OTHER TO VSS (+/-)
ALL OTHER TO VSS\_PLL (+/-)
ALL OTHER TO VSS\_CODEC (+/-)
ALL OTHER TO VCC (+/-)
ALL OTHER TO AVDD\_PLL (+/-)
ALL OTHER TO VDD\_CODEC.A (+/-)
ALL OTHER TO VDD\_CODEC.B (+/-)
ALL OTHER TO VDD12 (+/-)
IO TO IO (+/-)
2000V~8000V,step:1000V

Tested Pins -	Sample No. & Failed Volt			
	#01	#02	#03	
1	PASS(8000V)	PASS(8000V)	PASS(8000V)	
2	PASS(8000V)	PASS(8000V)	PASS(8000V)	
3	PASS(8000V)	PASS(8000V)	PASS(8000V)	
4	PASS(8000V)	PASS(8000V)	PASS(8000V)	
5	PASS(8000V)	PASS(8000V)	PASS(8000V)	
6	PASS(8000V)	PASS(8000V)	PASS(8000V)	
7	PASS(8000V)	PASS(8000V)	PASS(8000V)	
8	PASS(8000V)	PASS(8000V)	PASS(8000V)	
9	PASS(8000V)	PASS(8000V)	PASS(8000V)	
10	PASS(8000V)	PASS(8000V)	PASS(8000V)	
11	PASS(8000V)	PASS(8000V)	PASS(8000V)	
12	PASS(8000V)	PASS(8000V)	PASS(8000V)	
13	PASS(8000V)	PASS(8000V)	PASS(8000V)	
14	PASS(8000V)	PASS(8000V)	PASS(8000V)	
15	PASS(8000V)	PASS(8000V)	PASS(8000V)	
16	PASS(8000V)	PASS(8000V)	PASS(8000V)	
17	PASS(8000V)	PASS(8000V)	PASS(8000V)	
18	PASS(8000V)	PASS(8000V)	PASS(8000V)	
19	PASS(8000V)	PASS(8000V)	PASS(8000V)	
20	PASS(8000V)	PASS(8000V)	PASS(8000V)	
21	PASS(8000V)	PASS(8000V)	PASS(8000V)	
22	PASS(8000V)	PASS(8000V)	PASS(8000V)	
23	PASS(8000V)	PASS(8000V)	PASS(8000V)	
24	PASS(8000V)	PASS(8000V)	PASS(8000V)	
25	PASS(8000V)	PASS(8000V)	PASS(8000V)	
26	PASS(8000V)	PASS(8000V)	PASS(8000V)	
27	PASS(8000V)	PASS(8000V)	PASS(8000V)	
28	PASS(8000V)	PASS(8000V)	PASS(8000V)	
29	PASS(8000V)	PASS(8000V)	PASS(8000V)	
30	PASS(8000V)	PASS(8000V)	PASS(8000V)	
31	PASS(8000V)	PASS(8000V)	PASS(8000V)	
32	PASS(8000V)	PASS(8000V)	PASS(8000V)	
33	PASS(8000V)	PASS(8000V)	PASS(8000V)	
34	PASS(8000V)	PASS(8000V)	PASS(8000V)	
35	PASS(8000V)	PASS(8000V)	PASS(8000V)	
36	PASS(8000V)	PASS(8000V)	PASS(8000V)	
37	PASS(8000V)	PASS(8000V)	PASS(8000V)	
38	PASS(8000V)	PASS(8000V)	PASS(8000V)	

# INTEGRATED SERVICE TECHNOLOGY

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#### Integrated Service Technology Inc.

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PASS(8000V)

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PASS(8000V)

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39	PASS(8000V)	PASS(8000V)	PASS(8000V)
40	PASS(8000V)	PASS(8000V)	PASS(8000V)
41	PASS(8000V)	PASS(8000V)	PASS(8000V)
42	PASS(8000V)	PASS(8000V)	PASS(8000V)
43	PASS(8000V)	PASS(8000V)	PASS(8000V)
44	PASS(8000V)	PASS(8000V)	PASS(8000V)
45	PASS(8000V)	PASS(8000V)	PASS(8000V)
46	PASS(8000V)	PASS(8000V)	PASS(8000V)
47	PASS(8000V)	PASS(8000V)	PASS(8000V)
48	PASS(8000V)	PASS(8000V)	PASS(8000V)
49	FAIL(5000V)	FAIL(5000V)	FAIL(5000V)
50	PASS(8000V)	PASS(8000V)	PASS(8000V)
51	FAIL(5000V)	PASS(8000V)	PASS(8000V)
52	PASS(8000V)	PASS(8000V)	PASS(8000V)
53	PASS(8000V)	PASS(8000V)	PASS(8000V)
54	PASS(8000V)	PASS(8000V)	PASS(8000V)
55	PASS(8000V)	PASS(8000V)	PASS(8000V)
56	PASS(8000V)	PASS(8000V)	PASS(8000V)

PASS(8000V)